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features common to all types

- Single 5-V Supply
- 3-State Driver Output Circuitry
- TTL-Compatible Driver Inputs
- TTL-Compatible Receiver Output
- Differential Line Operation
- Receiver Output Strobe (SN55116, SN75116, SN75117) or Enable (SN75118, SN75119)
- Designed for Party-Line (Data-Bus) Applications

additional features of the SN55116/SN75116

- Choice of Ceramic or Plastic Packages
- Independent Driver and Receiver
- Choice of Open-Collector or Totem-Pole Outputs on Both Driver and Receiver
- Dual Data Inputs on Driver
- Optional Line-Termination Resistor in Receiver
- ±15-V Receiver Common-Mode Capability
- Receiver Frequency-Response Control

additional features of the SN75117

 Driver Output Internally Connected to Receiver Input

The SN75118 is an SN75116 With 3-State Receiver Output Circuitry The SN75119 is an SN75117 With 3-State Receiver Output Circuitry

description

These integrated circuits are designed for use in interfacing between TTL-type digital systems and differential data-transmission lines. They are especially useful for party-line (data-bus) applications. Each of these circuit types combine in one package a 3-state differential line driver and a differential-input line receiver, both of which operate from a single 5-V power supply. The driver inputs and the receiver outputs are TTL compatible. The driver employed is similar to the SN55113 and SN75113 3-state line drivers, and the receiver is similar to the SN55115 and SN75115 line receivers.

The SN55116, SN75116, and SN75118 offer all the features of the SN55113 and SN75113 drivers and the SN55115 and SN75115 receivers combined. The driver performs the dual input AND and NAND functions when enabled or presents a high impedance to the load when in the disabled state. The driver output stages are similar to TTL totem-pole outputs, but have the current-sinking portion separated from the current-sourcing portion and both are brought out to adjacent package terminals. This feature allows the user the option of using the driver in the open-collector output configuration, or, by connecting the adjacent source and sink terminals together, of using the driver in the normal totem-pole output configuration.

The receiver portion of the SN55116, SN75116, and SN75118 features a differential-input circuit having a common-mode voltage range of ± 15 V. An internal 130- Ω equivalent resistor also is provided, which optionally can be used to terminate the transmission line. A frequency-response control terminal allows the user to reduce the speed of the receiver or to improve differential noise immunity. The receivers of the SN55116 and SN75116 have an output strobe and a split totem-pole output. The receiver of the SN75118 has an output-enable for the 3-state split totem-pole output. The receiver section of either circuit is independent of the driver section except for the V_{CC} and ground terminals.

The SN75117 and SN75119 provide the basic driver and receiver functions of the SN55116, SN75116, and SN75118, but use a package that is only half as large. The SN75117 and SN75119 are intended primarily for party-line or bus-organized systems because the driver outputs are internally connected to the receiver inputs. The driver has a single data input and a single enable input. The SN75117 receiver has an output strobe, while the SN75119 receiver has a 3-state output enable. However, these devices do not provide output connection options, line-termination resistors, or receiver frequency-response controls.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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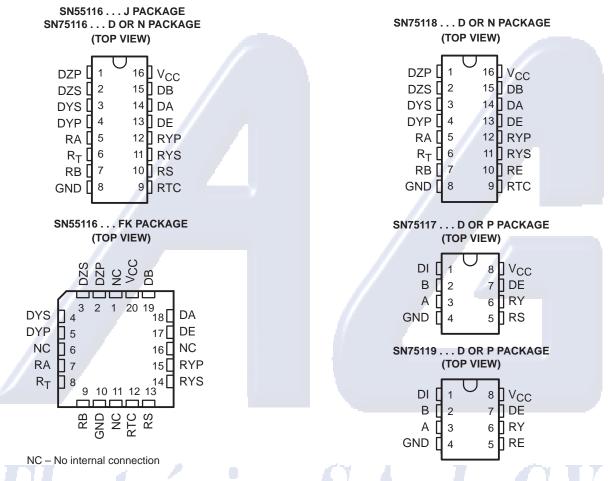


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description (continued)

The SN55116 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN75116, SN75117, SN75118, and SN75119 are characterized for operation from 0°C to 70°C.



Function Tables

'116, SN75118 DRIVER

ll li	NPUTS	OUTPUTS				
DE	DA	DB	DY	DZ		
L	Х	Х	Z	Z		
Н	L	X	L	Н		
Н	X	L	L	Н		
Н	Н	Н	Н	L		

'116, SN75118 **RECEIVER**

RS/RE	DIFF	OUTPUTS RY					
K3/KE	INPUT	'116	SN75118				
L	Χ	Н	Z				
Н	L	Н	Н				
Ιн	Н	lι	L				

SN75117, SN75119 DRIVER

INP	UTS	OUTPUTS					
DI	DE	Α	В				
Н	н н		L				
L	L H		Н				
X	L	Z	Z				

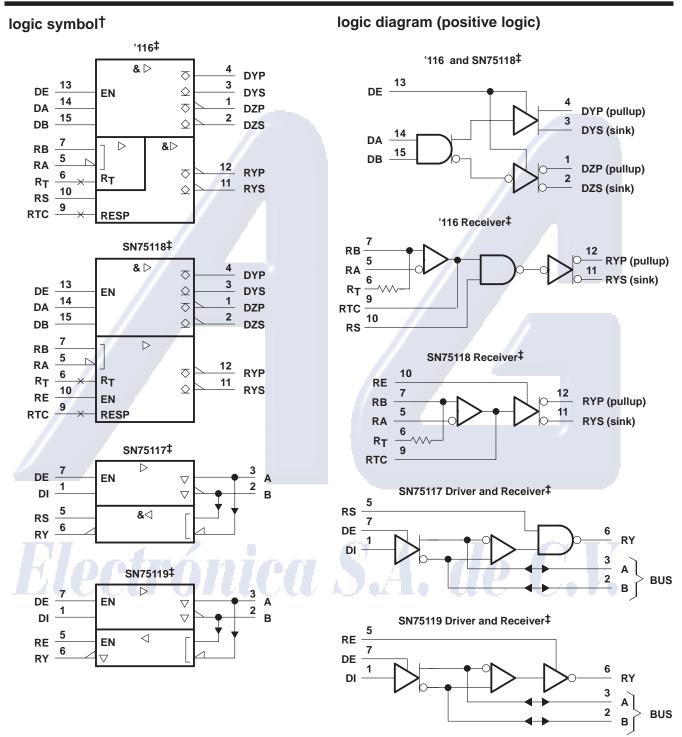
SN75117, SN75119 **RECEIVER**

		INPU	TS	OUTPUT RY					
	Α	В	RS/RE	SN75117	SN75119				
Г	Н	L	Н	Н	Н				
	L	Н	Н	L	L				
	Χ	Χ	L	Н	Z				

H = high level ($V_1 \ge V_{1H}$ min or V_{1D} more positive than V_{TH} max), L = low level ($V_1 \le V_{1L}$ max or V_{1D} more negative than V_{TL} max), X = irrelevant, Z = high impedance (off)



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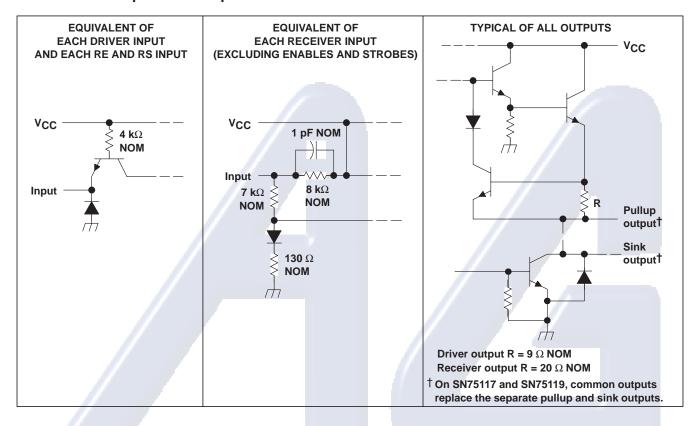


[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

[‡] Pin numbers shown for the SN55116 and SN75116 are for the D, J, and N packages, those shown for the SN75118 are for the D and N packages, and those shown for SN75117 and SN75119 are for the D and P packages.

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schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature (unless otherwise noted)‡

Supply voltage, V _{CC} (see Notes 1 and 2)	. 7 V
Input voltage, V _I : DA, DB, DE, DI, RE, and RS	5.5 V
RA, RB, R _T for '116, SN75118 only	±25 V
A and B for SN75117, SN75119 only 0 t	to 6 V
Off-state voltage applied to open-collector outputs: '116, SN75118 only	12 V
Continuous total power dissipation (see Note 2) See Dissipation Rating	Table
Storage temperature range, T _{stg} –65°C to 1	50°C
Case temperature for 60 seconds, T _C : FK package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J package	300°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D, N, or P package	260°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values are with respect to the network ground terminal.
 - 2. In the FK and J packages, the SN55116 chip is alloy mounted. The SN75116, SN75117, SN75118, and SN75119 chips are glass mounted.



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DISSIPATION RATING TABLE

PACKAGE	$T_{\mbox{\scriptsize A}} \le 25^{\circ}\mbox{\scriptsize C}$ POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 125°C POWER RATING
D (8 pin)	725 mW	5.8 mW/°C	464 mW	_
D (16 pin)	950 mW	7.6 mW/°C	608 mW	_
FK	1375 mW	11.0 mW/°C	880 mW	275 mW
J	1375 mW	11.0 mW/°C	880 mW	275 mW
N	1150 mW	9.2 mW/°C	736 mW	//-
Р	1000 mW	8.0 mW/°C	640 mW	//-

recommended operating conditions

PARAMETER	A			SN55116		SN751 SN75	5117, 5119	UNIT		
			MIN	NOM	MAX	MIN	NOM	MAX		
Supply voltage, V _{CC}			4.5	5	5.5	4.5	5	5.5	V	
High-level input voltage, V _{IH}	All inputs excep	t differential	2	//		2			V	
Low-level input voltage, V _{IL}	inputs				0.8			0.8	V	
High-level output current, IOH	Drivers				-40			-40	mA	
Triigh-level output current, IOH	Receivers				-5	/		-5	ША	
Low-level output current, IOI	Drivers		/		40			40	mA	
Low-level output current, IOL	Receivers				15			15	IIIA	
Receiver input voltage, V	'116, SN75118				±15			±15	V	
Receiver input voltage, v	SN75117, SN75	5119	0		6	0		6	V	
Common-mode receiver input voltage, VICR	'116, SN75118				±15		7/	±15		
Common-mode receiver input voltage, VICR	SN75117, SN75	5119	0		6	0		6	V	
Operating free-air temperature, TA			-55		125	0		70	°C	

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

driver section

			7	Á		'116	s, SN751	18	SN751	17, SN7	5119	
	PARAMETER			TEST CONDITIONST		MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	Input clamp voltage	- 7/	V _{CC} = MIN,	I _I = -12 mA			-0.9	-1.5		-0.9	-1.5	V
	High-level output voltage			T _A = 25°C (SN55116), T _A = 0°C to 70°C	I _{OH} = -10 mA	2.4	3.4		2.4	3.4		
Vон			V _{CC} = MIN, V _{IL} = 0.8 V, I _{IH} = 2 V	(SN75116, SN75117, SN75118, SN75119)	I _{OH} = -40 mA	2	3		2	3		٧
			'IH - 2 V	T _A = -55°C to 125°C (SN55116)	$I_{OH} = -10 \text{ mA}$	2			2			
				(SN55116)	$I_{OH} = -40 \text{ mA}$	1.8			1.8			
VOL	Low-level output voltage		V _{CC} = MIN,	$V_{CC} = MIN$, $V_{IH} = 2 V$, $V_{IL} = 0.8 V$, $I_{OL} = 40 \text{ mA}$				0.4			0.4	V
Vок	Output clamp voltage		$V_{CC} = MAX$,	$I_O = -40 \text{ mA}, DE \text{ at } 0.8 \text{ V}$				-1.5			-1.5	V
				T _A = 25°C			1	10				
I _{O(off)}	Off-state open-collector output current		$V_{CC} = MAX,$ $V_{O} = 12 V$		SN55116			200			μА	ıı A
.0(011)	on state open, sensole, sen	r state open concetor curput current		$T_A = MAX$	SN75116, SN75118			20				μ.,
			$V_{CC} = MAX$,	$V_O = 0$ to V_{CC} , DE at 0.8 V,	T _A = 25°C			±10				
	Off-state (high-impedance-	stato)	V _{CC} = MAX,	V _O = 0	SN55116			-300				
loz	output current	state)	DE at 0.8 V.	$V_O = 0.4 \text{ V to } V_{CC}$	SN55116			±150				μА
			$T_A = MAX$	V _O = 0 to V _{CC}	SN75116, SN75118		±20					
h .	Input current at maximum input voltage	Driver or	V _{CC} = MAX,	V _I = 5.5 V				1			1	mA
lн	High-level input current	enable input	V _{CC} = MAX,	V _I = 2.4 V	-			40			40	μА
Ι _Ι L	Low-level input current		V _{CC} = MAX,	V _I = 0.4 V				-1.6			-1.6	mA
los	Short-circuit output current	§	V _{CC} = MAX,	$V_{CC} = MAX$, $V_{O} = 0$, $V_{A} = 25^{\circ}C$				-120	-40		-120	mA
lcc	Supply current (driver and combined)	receiver	V _{CC} = MAX,	T _A = 25°C			42	60	42		60	mA

[†] All parameters with the exception of off-state open-collector output current are measured with the active pullup connected to the sink output. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V and T_A = 25°C.

§ Not more than one output should be shorted at a time, and duration of the short circuit should not exceed one second.



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switching characteristics, V_{CC} = 5 V, C_L = 30 pF, T_A = 25°C

driver section

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
^t PLH	Propagation-delay time, low-to-high level output	See Figure 13		14	30	nc
tPHL	Propagation-delay time, high-to-low level output	See rigule 13		12	30	ns
^t PZH	Output-enable time to high level	$R_L = 180 \Omega$, See Figure 14		8	20	ns
tPZL	Output-enable time to low level	$R_L = 250 \Omega$, See Figure 15		17	40	ns
tPHZ	Output-disable time from high level	R_L = 180 Ω, See Figure 14		16	30	ns
tPLZ	Output-disable time from low level	$R_L = 250 \Omega$, See Figure 15	1	20	35	ns



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

receiver section

	PARAMETER		7/	TEST SOUR	Tieviet	'11	6, SN751	18	SN75	117, SN7	5119	UNIT
	PARAMETER			TEST CONDI	TIONSI	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNII
M	Positive-going threshold vol	8	V _O = 0.4 V,	I _{OL} = 15 mA,	V _{CC} = MIN, V _{ICR} = 0, See Note 4		7	0.5			0.5	V
V _{IT+}	VIII + Positive-going the should voltages	nages	See Note 3		V _{CC} = 5 V, V _{ICR} = MAX, See Note 5	//		1			1	V
V	No. of the state o	8	V _O = 2.4 V,	I _{OL} = -5 mA,	V _{CC} = MIN, V _{ICR} = 0, See Note 4	-0.5¶			-0.5¶			V
VIT-	Negative-going threshold vo	onages	See Note 3		V _{CC} = 5 V, V _{ICR} = MAX, See Note 5	-1¶			-1¶		V	
VI	Input voltage range#		V _{CC} = 5 V,	V _{ID} = -1 V or 1 V,	See Note 3	15 to -15		//	6 to 0			V
Vон			I _{OH} = -5 mA,	V _{CC} = MIN, V _{ICR} = 0,	V _{ID} = -0.5 V, See Notes 4 and 6	2.4			2.4			V
VOH	High-level output voltage		See Note 3	V _{CC} = 5 V, V _{ICR} = MAX,	V _{ID} = -1 V, See Note 5	2.4			2.4			V
Voi	Low-level output voltage		I _{OL} = 15 mA,	V _{CC} = MIN, V _{ICR} = 0,	V _{ID} = 0.5 V, See Notes 4 and 7			0.4			0.4	V
VOL	Low-level output voltage		See Note 3	V _{CC} = 5 V, V _{ICR} = MAX,	V _{ID} = 1 V, See Note 5			0.4			0.4	V
			V. MAY	V _I = 0,	Other input at 0 V		-0.5	-0.9		-0.5	-1	
I _{I(rec)}	I(rec) Receiver input current		V _{CC} = MAX, See Note 3	V _I = 0.4 V,	Other input at 2.4 V		-0.4	-0.7		-0.4	-0.8	mA
	,		V _I = 2.4 V,	Other input at 0.4 V	0.1 0.3			0.1	0.4			
	Input current at maximum input voltage	Strobe	V _{CC} = MIN, V _{strobe} = 4.5 V	$V_{ID} = -0.5 V$,	'116, SN75117			5			5	μΑ
	input voitage	Enable	V _{CC} = MAX,	V _I = 5.5 V	SN75118, SN75119			1		Y	1	mA

[†] Unless otherwise noted, V_{strobe} = 2.4 V. All parameters, with the exception of off-state open-collector output current, are measured with the active pullup connected to the sink output. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

- - This applies with the less positive receiver input grounded.
 - 5. For '116 and SN75118, this applies with the more positive receiver input at 15 V or the more negative receiver input at 15 V. For SN75117 and SN75119, this applies with the more positive receiver input at 6 V.
 - For SN55116, $V_{ID} = -1 \text{ V}$
 - For SN55116, V_{ID} = 1 V



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[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$, and $V_{IC} = 0$.

[§] Differential voltages are at the B input terminal with respect to the A input terminal. Neither receiver input of the SN75117 or SN75119 should be taken negative with respect to GND.

¹ The algebraic convention, where the less positive (more negative) limit is designated as minimum, is used in this data sheet for threshold voltages only.

Input voltage range is the voltage range that, if exceeded at either input, will cause the receiver to cease functioning properly.

NOTES: 3. Measurement of these characteristics on the SN75117 and SN75119 requires the driver to be disabled with the driver enable at 0.8 V.

receiver section (continued)

			17				S, SN751	18	SN75	117, SN7	75119	
	PARAMETER			TEST CONDITION	st	MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	UNIT
lін	High-level input current	Enable	V _{CC} = MAX,	V _I = 2.4 V	SN75118, SN75119		77	40			40	μΑ
l _l	Low-level input current	Strobe	V _{CC} = MAX, V _{strobe} = 0.4 V,	V _{ID} = 0.5 V, See Notes 4 and 7	'116, SN75117		/	-2.4			-2.4	mA
		Enable	V _{CC} = MAX,	V _I = 0.4 V	SN75118, SN75119	1//		-1.6			-1.6	
I(RTC)	Response-time-control curr	ent (RTC)	V _{CC} = MAX, RC at 0 V,	V _{ID} = 0.5 V, See Notes 4 and 7	T _A = 25°C	-1.2						mA
			V _{CC} = MAX,	T _A = 25°C			1	10				
IO(off)	Off-state open-collector out	put current	V _O = 12 V,		SN55116			200	7			μΑ
			V _{ID} = -1 V		SN75116, SN75118			20				
			V _{CC} = MAX,	T _A = 25°C	SN75118, SN75119			±10			±10	
loz	Off-state (high-impedance-s output current	state)	$V_O = 0$ to V_{CC} ,	T MAY	SN75118			±20				μΑ
	output ourroin		RE at 0.4 V	T _A = MAX	SN75119						±20	
R _T	Line-terminating resistance		V _{CC} = 5 V		T _A = 25°C	77		167				Ω
los	Short-circuit output current§	}	$V_{CC} = MAX,$ $V_{ID} = -0.5 V,$	V _O = 0, See Notes 4 and 6	T _A = 25°C	-15		-80	-15	٠,	-80	mA
lcc /	Short current (driver and receiver combined)	·	V _{CC} = MAX, See Notes 4 and	V _{ID} = 0.5 V,	T _A = 25°C		42	60		42	60	mA

[†] Unless otherwise noted, V_{strobe} = 2.4 V. All parameters, with the exception of off-state open-collector output current, are measured with the active pullup connected to the sink output. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V, T_A = 25°C, and V_{IC} = 0.

§ Not more than one output should be shorted at a time.

NOTES: 4. This applies with the less positive receiver input grounded.

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^{6.} For SN55116, V_{ID} = -1 V 7. For SN55116, V_{ID} = 1 V

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switching characteristics, V_{CC} = 5 V, C_L = 30 pF, T_A = 25°C

receiver section

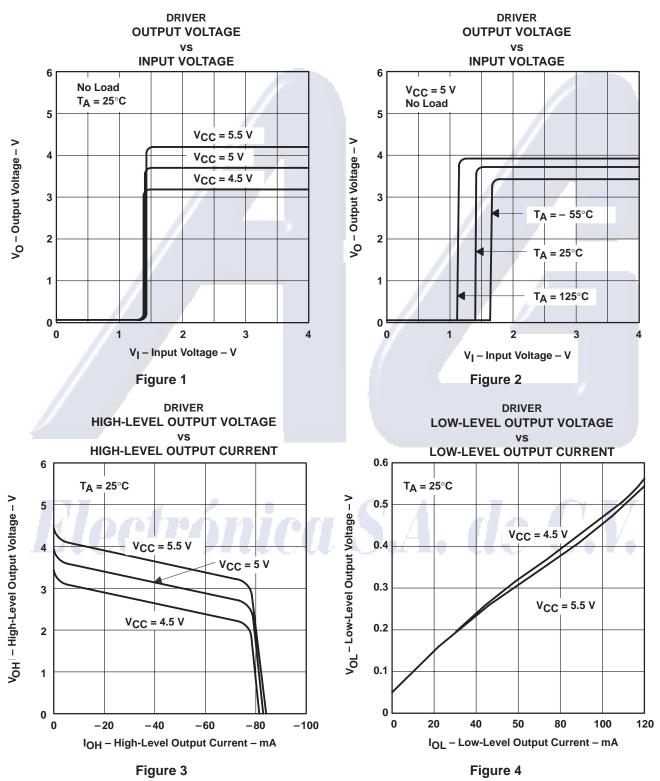
	PARAMETER	TEST C	CONDITIONS	MIN	TYP	MAX	UNIT	
^t PLH	Propagation-delay time, low-to-high-level output	P. – 400 O	See Figure 16		20	75	ns	
^t PHL	Propagation-delay time, high-to-low-level output	ıt	$R_L = 400 \Omega$,	See Figure 16		17	75	ns
^t PZH	Output-enable time to high level	SN75118	$R_L = 480 \Omega$,	See Figure 14		9	20	ns
tPZL	Output-enable time to low level	and	$R_L = 250 \Omega$,	See Figure 15		16	35	ns
^t PHZ	Output-disable time from high level	SN75119	$R_L = 480 \Omega$,	See Figure 14	//	12	30	ns
tPLZ	Output-disable time from low level	only	$R_L = 250 \Omega$,	See Figure 15	7	17	35	ns





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TYPICAL CHARACTERISTICS[†]

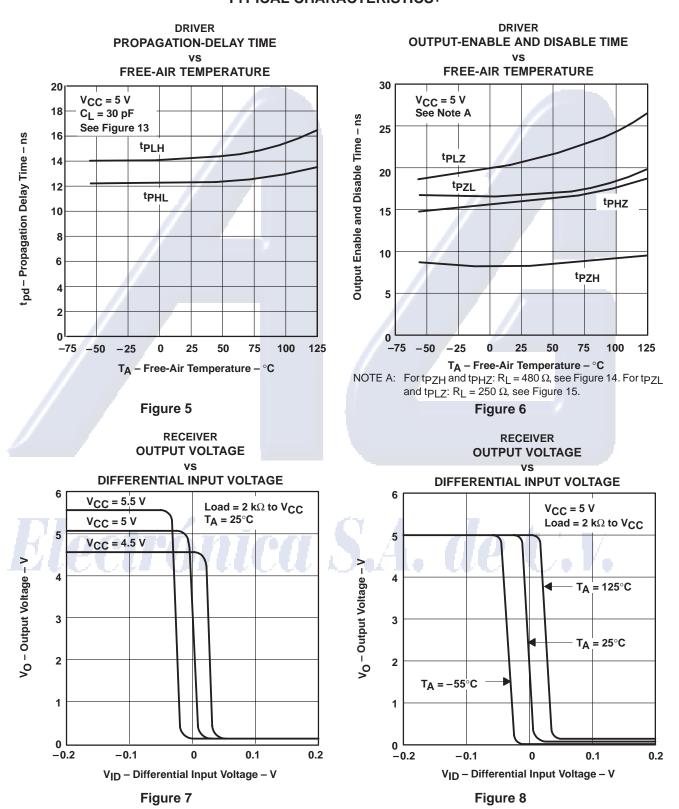


[†]Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.



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TYPICAL CHARACTERISTICS†

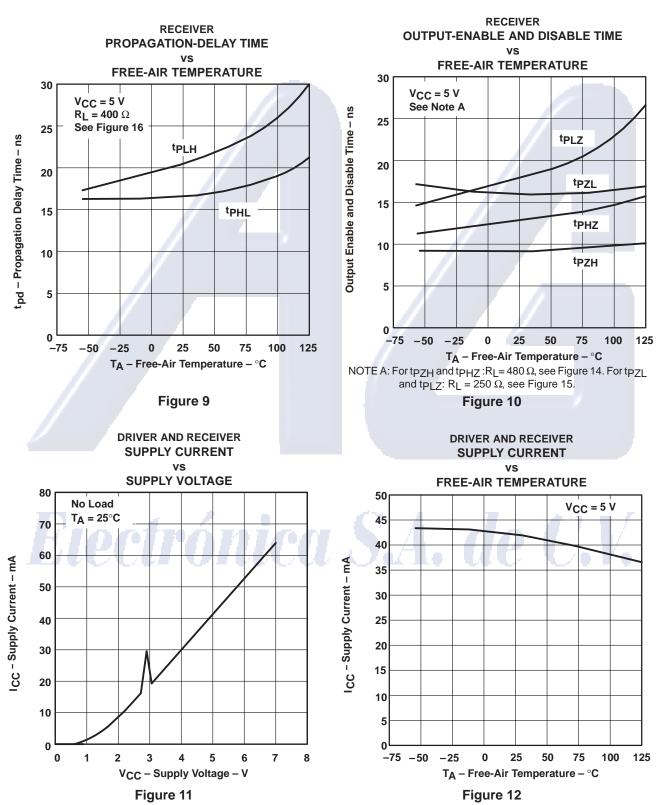


[†] Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.



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TYPICAL CHARACTERISTICS†

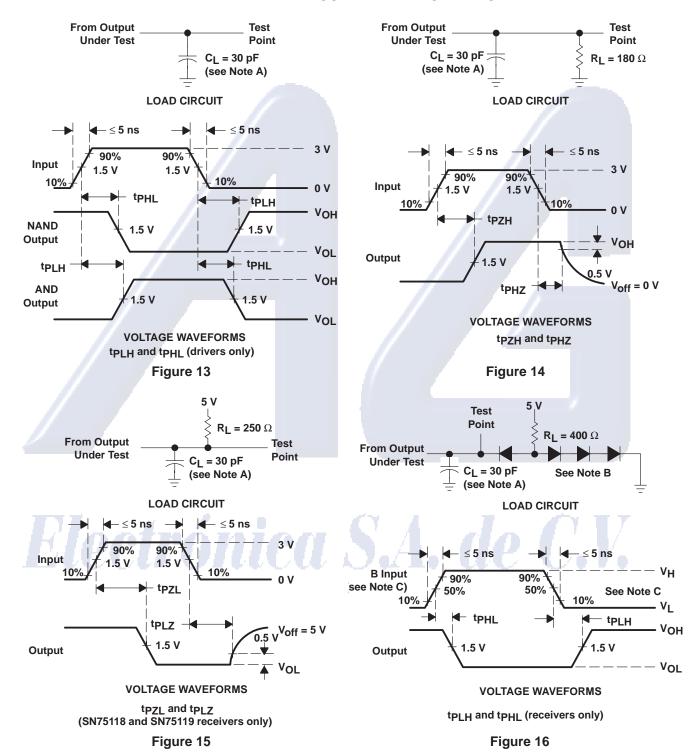


[†] Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.



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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_I includes probe and jig capacitance.
 - B. All diodes are 1N3064 or equivalent.
 - C. For '116 and SN75118, V $_H$ = 3 V, V $_L$ = 3 V, the A input is at 0 V. For SN75117 and SN75119, V $_H$ = 3 V, V $_L$ = 0, the A input is at 1.5 V.
 - D. When testing the '116 and SN75118 receiver sections, the response-time control and the termination resistor pins are left open.



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